Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/645,882	WELCH, JOHN T.
Examiner	Art Unit
Richard L. Leung	3744

SEARCHED					
Class	Subclass	Date	Examiner		
62	3.2, 3.3, 3.4, 3.7	9/9/2005	RLL		
62	3.2, 3.3, 34, 3.7	3/21/2006	BCM		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
See A	Hached	3/21/2006	BCM	
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SEARCH NOT (INCLUDING SEARCH		
	DATE	EXMR
Consulted Examiner Doerrier AU3744	9/9/2005	RLL
See EAST search history printout	10/3/2005	RLL
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